

CMOS NOR Gates

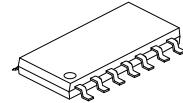
High-Voltage Types

■ DESCRIPTION

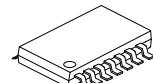
UCD4002B NOR gate provides the system designer with direct implementation of the NOR function and supplements the existing family of CMOS gates. All inputs and outputs are buffered.

■ FEATURES

- * Propagation delay time=60ns at $C_L=50\text{pF}$, $V_{DD}=10\text{V}$
- * Buffered inputs and outputs
- * Maximum input current of $1\mu\text{A}$ at 18V
- * Standardized symmetrical output characteristics
- * 100% tested for maximum quiescent current at 20V



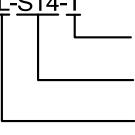
SOP-14



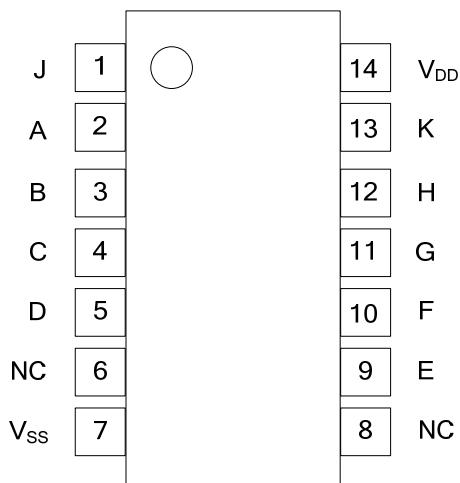
TSSOP-14

■ ORDERING INFORMATION

Ordering Number		Package	Packing
Lead Free	Halogen Free		
UCD4002BL-S14-T	UCD4002BG-S14-T	SOP-14	Tube
UCD4002BL-S14-R	UCD4002BG-S14-R	SOP-14	Tape Reel
UCD4002BL-P14-T	UCD4002BG-P14-T	TSSOP-14	Tube
UCD4002BL-P14-R	UCD4002BG-P14-R	TSSOP-14	Tape Reel

UCD4002BL-S14-T 	(1)Packing Type (2)Package Type (3)Halogen Free (1) T: Tube, R: Tape Reel (2) S14: SOP-14, P14: TSSOP-14 (3) L: Lead Free, G: Halogen Free
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PIN CONFIGURATION

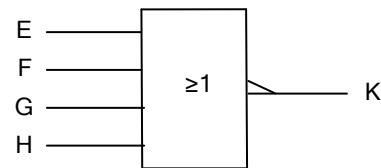
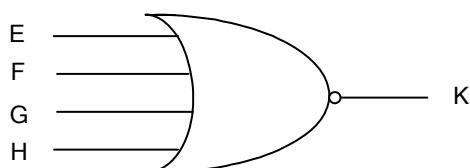
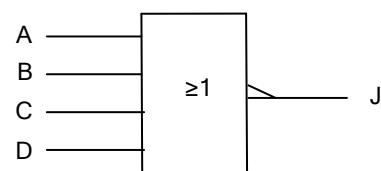
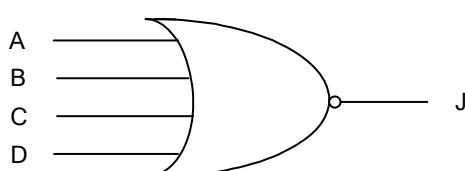


■ FUNCTION TABLE

INPUT	OUTPUT	OUTPUT							
A	B	C	D	E	F	G	H	K	J
L	L	L	L	L	L	L	L	H	H
H	X	X	X	H	X	X	X	L	L
X	H	X	X	X	H	X	X	L	L
X	X	H	X	X	X	H	X	L	L
X	X	X	H	X	X	X	H	L	L

NOTE: X = DON'T CARE CASE

■ LOGIC DIAGRAM



■ ABSOLUTE MAXIMUM RATING ($T_A = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT
Supply Voltage	V_{DD}	-0.5 ~ 20	V
Input Voltage	V_{IN}	-0.5 ~ $V_{CC} + 0.5$	V
Output Voltage	V_{OUT}	-0.5 ~ $V_{CC} + 0.5$	V
Power Dissipation($T_A = 55^\circ\text{C}$)	P_D	500	mW
Storage Temperature	T_{STG}	-65 ~ + 150	$^\circ\text{C}$

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Supply Voltage	V_{DD}		3	18		V
Operating Temperature	T_{OPR}		-40		125	$^\circ\text{C}$

■ ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
High-Level Input Voltage	V_{IH}	$V_{DD} = 5\text{V}, V_O = 0.5\text{V}$	3.5			V
		$V_{DD} = 10\text{V}, V_O = 1.0\text{V}$	7.0			
		$V_{DD} = 15\text{V}, V_O = 1.5\text{V}$	11.0			
Low-Level Input Voltage	V_{IL}	$V_{DD} = 5\text{V}, V_O = 4.5\text{V}$			1.5	V
		$V_{DD} = 10\text{V}, V_O = 9.0\text{V}$			3.0	
		$V_{DD} = 15\text{V}, V_O = 13.5\text{V}$			4.0	
High-Level Output Voltage	V_{OH}	$V_{DD} = 5\text{V}$, No Load	4.95	5		V
		$V_{DD} = 10\text{V}$, No Load	9.95	10		
		$V_{DD} = 15\text{V}$, No Load	14.95	15		
Low-Level Output Voltage	V_{OL}	$V_{DD} = 5\text{V}$, No Load		0	0.05	V
		$V_{DD} = 10\text{V}$, No Load		0	0.05	
		$V_{DD} = 15\text{V}$, No Load		0	0.05	
High-Level Output Current (Note)	I_{OH}	$V_{DD} = 5\text{V}, V_O = 4.6\text{V}$	-0.51	-1.0		mA
		$V_{DD} = 5\text{V}, V_O = 2.5\text{V}$	-1.6	-3.2		
		$V_{DD} = 10\text{V}, V_O = 9.5\text{V}$	-1.3	-2.6		
		$V_{DD} = 15\text{V}, V_O = 13.5\text{V}$	-3.4	-6.8		
Low-Level Output Current (Note)	I_{OL}	$V_{DD} = 5\text{V}, V_O = 0.4\text{V}$	0.51	1		μA
		$V_{DD} = 10\text{V}, V_O = 0.5\text{V}$	1.3	2.6		
		$V_{DD} = 15\text{V}, V_O = 1.5\text{V}$	3.4	6.8		
Input Leakage Current	$I_{I(LEAK)}$	$V_{DD} = 15\text{V}, V_{IN} = V_{DD}$ or GND			± 0.1	μA
Quiescent Supply Current	I_{DD}	$V_{DD} = 5\text{V}, V_{IN} = V_{DD}$ or V_{SS} , $I_{OUT} = 0$		0.01	0.25	μA
		$V_{DD} = 10\text{V}, V_{IN} = V_{DD}$ or V_{SS} , $I_{OUT} = 0$		0.01	0.5	
		$V_{DD} = 15\text{V}, V_{IN} = V_{DD}$ or V_{SS} , $I_{OUT} = 0$		0.01	1.0	
		$V_{DD} = 20\text{V}, V_{IN} = V_{DD}$ or V_{SS} , $I_{OUT} = 0$		0.02	5.0	

Note: I_{OL} and I_{OH} are tested one output at a time

■ SWITCHING CHARACTERISTICS

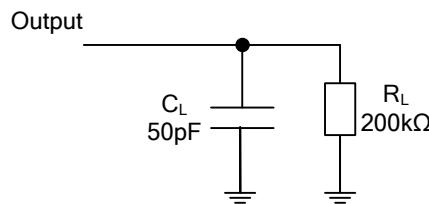
($T_A = 25^\circ C$, Input $t_r, t_f = 20\text{ns}$, $C_L = 50\text{pf}$, $R_L = 200\text{k}\Omega$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Propagation delay from Input(A or B) to Output(Y)	t_{PLH}	$V_{DD}=5V$		125	250	ns
		$V_{DD}=10V$		60	120	
		$V_{DD}=15V$		45	90	
	t_{PHL}	$V_{DD}=5V$		125	250	
		$V_{DD}=10V$		60	120	
		$V_{DD}=15V$		45	90	
Transition Time	t_{TLH}, t_{THL}	$V_{DD}=5V$		100	200	ns
		$V_{DD}=10V$		50	100	
		$V_{DD}=15V$		40	80	

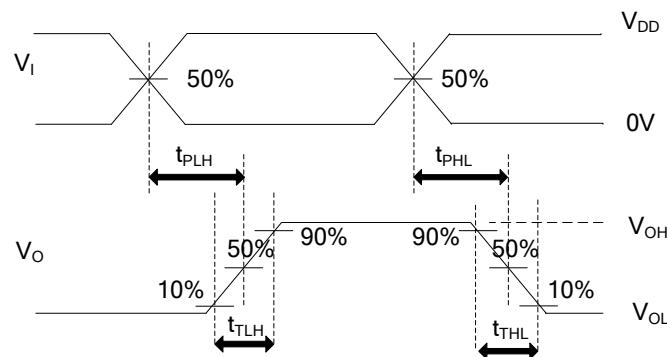
■ OPERATING CHARACTERISTICS($T_A=25^\circ C$,unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Average Input Capacitance	C_{IN}	Any Input		5	7.5	pF

- TEST CIRCUIT AND WAVEFORMS



Definitions for test circuit



Propagation Delay Times

Note: C_L includes probe and jig capacitance.

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